

August 2014

# FDP51N25 / FDPF51N25 N-Channel UniFET<sup>TM</sup> MOSFET 250 V, 51 A, 60 m $\Omega$

## **Features**

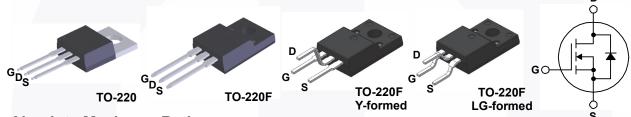
- $R_{DS(on)}$  = 48 m $\Omega$  (Typ.) @  $V_{GS}$  = 10 V,  $I_{D}$  = 25.5 A
- Low Gate Charge (Typ. 55 nC)
- Low C<sub>rss</sub> (Typ. 63 pF)

# **Applications**

- PDP TV
- Lighting
- · Uninterruptible Power Supply
- AC-DC Power Supply

## Description

UniFET<sup>TM</sup> MOSFET is Fairchild Semiconductor's high voltage MOSFET family based on planar stripe and DMOS technology. This MOSFET is tailored to reduce on-state resistance, and to provide better switching performance and higher avalanche energy strength. This device family is suitable for switching power converter applications such as power factor correction (PFC), flat panel display (FPD) TV power, ATX and electronic lamp ballasts.



Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted.

Symbol	Para	ameter	FDP51N25	FDPF51N25 FDPF51N25YDTU FDPF51N25RDTU	Unit
V <sub>DSS</sub>	Drain-Source Voltage		250	V	
I <sub>D</sub>	Drain Current	- Continuous (T <sub>C</sub> = 25°C) - Continuous (T <sub>C</sub> = 100°C)	51 51* 30 30*		A A
I <sub>DM</sub>	Drain Current	- Pulsed (Note 1)	204	204*	Α
V <sub>GSS</sub>	Gate-Source voltage			V	
E <sub>AS</sub>	Single Pulsed Avalanche Ene	ergy (Note 2)		mJ	
I <sub>AR</sub>	Avalanche Current (Note 1)		51		Α
E <sub>AR</sub>	Repetitive Avalanche Energy (Note 1)		32		mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)		4.5		V/ns
P <sub>D</sub>	Power Dissipation	(T <sub>C</sub> = 25°C) - Derate Above 25°C	320 3.7	38 0.3	W/°C
T <sub>J,</sub> T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150		°C
T <sub>L</sub>	Maximum Lead Temperature for Soldering, 1/8" from Case for 5 Seconds		300		°C

<sup>\*</sup>Drain current limited by maximum junction temperature.

## **Thermal Characteristics**

Symbol	Parameter	FDP51N25	FDPF51N25 FDPF51N25YDTU FDPF51N25RDTU	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	0.39	3.3	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient, Max.	62.5	62.5	°C/W

# **Package Marking and Ordering Information**

Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FDP51N25	FDP51N25	TO-220	Tube	N/A	N/A	50 units
FDPF51N25	FDPF51N25	TO-220F	Tube	N/A	N/A	50 units
FDPF51N25YDTU	FDPF51N25	TO-220F (Y-formed)	Tube	N/A	N/A	50 units
FDPF51N25RDTU	FDPF51N25	TO-220F (LG-formed)	Tube	N/A	N/A	50 units

# **Electrical Characteristics** $T_C = 25^{\circ}C$ unless otherwise noted.

Symbol	Parameter	Conditions		Тур.	Max.	Unit
Off Charac	cteristics			l	I	
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS}$ = 0 V, $I_{D}$ = 250 $\mu$ A, $T_{J}$ = 25 $^{\circ}$ C	250			V
ΔBV <sub>DSS</sub> / ΔT <sub>J</sub>	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C		0.25		V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 250 \text{ V}, V_{GS} = 0 \text{ V}$ $V_{DS} = 200 \text{ V}, T_{C} = 125^{\circ}\text{C}$			1 10	μA μA
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V			100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0V			-100	nA
On Charac	cteristics			l		
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}$ , $I_{D} = 250 \mu A$	3.0		5.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 25.5 A		0.048	0.060	Ω
9 <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> = 40 V, I <sub>D</sub> = 25.5 A		43		S
Dynamic C	Characteristics					
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V,		2620	3410	pF
C <sub>oss</sub>	Output Capacitance	f = 1 MHz		530	690	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			63	90	pF
Switching	Characteristics					
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> = 125 V, I <sub>D</sub> = 51 A,		62	135	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ = 10 V, $R_{G}$ = 25 $\Omega$	/	465	940	ns
t <sub>d(off)</sub>	Turn-Off Delay Time			98	205	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4)		130	270	ns
Qg	Total Gate Charge	V <sub>DS</sub> = 200 V, I <sub>D</sub> = 51 A,		55	70	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 10 V		16		nC
$Q_{gd}$	Gate-Drain Charge	(Note 4)		27		nC
Drain-Sou	rce Diode Characteristics and Maximur	n Ratings				
I <sub>S</sub>	Maximum Continuous Drain-Source Dio	de Forward Current			51	Α
I <sub>SM</sub>	Maximum Pulsed Drain-Source Diode F	orward Current			204	Α
$V_{SD}$	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 51 A			1.4	>
t <sub>rr</sub>	Reverse Recovery Time	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 51 A,		178		ns
Q <sub>rr</sub>	Reverse Recovery Charge	dl <sub>F</sub> /dt =100 A/μs		4.0		μС

 $<sup>{\</sup>it 1. Repetitive\ rating: pulse-width\ limited\ by\ maximum\ junction\ temperature.}$ 

<sup>2.</sup> L = 0.68 mH, I $_{AS}$  = 51 A, V $_{DD}$  = 50 V, R $_{G}$  = 25  $\Omega$ , starting T $_{J}$  = 25°C.

<sup>3.</sup>  $I_{SD} \le 51$  A, di/dt  $\le 200$  A/ $\mu$ s,  $V_{DD} \le BV_{DSS}$ , starting  $T_J = 25^{\circ}C$ . 4. Essentially independent of operating temperature typical characteristics.

# **Typical Performance Characteristics**

Figure 1. On-Region Characteristics

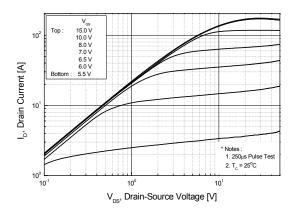


Figure 3. On-Resistance Variation vs.

Drain Current and Gate Voltage

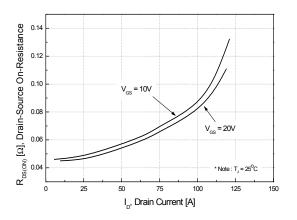
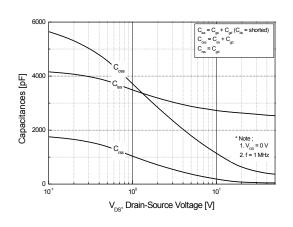


Figure 5. Capacitance Characteristics



**Figure 2. Transfer Characteristics** 

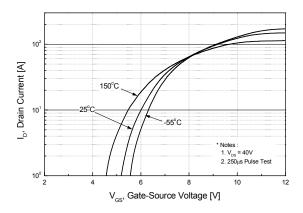


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperatue

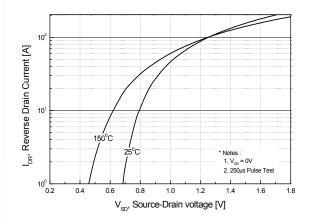
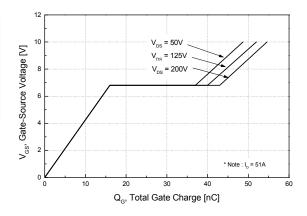


Figure 6. Gate Charge Characteristics



# Typical Performance Characteristics (Continued)

Figure 7. Breakdown Voltage Variation vs. Temperature

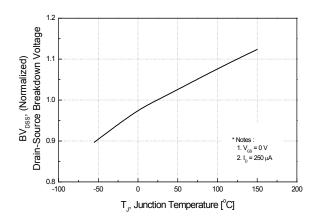


Figure 9-1. Maximum Safe Operating Area for FDP51N25



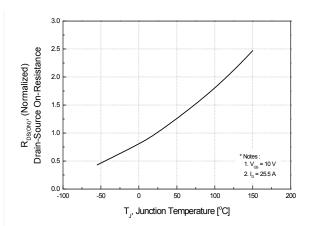


Figure 9-2. Maximum Safe Operating Area for FDPF51N25 / FDPF51N25YDTU

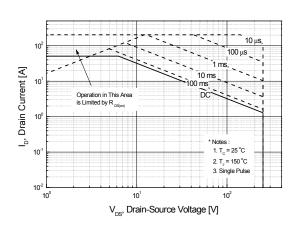
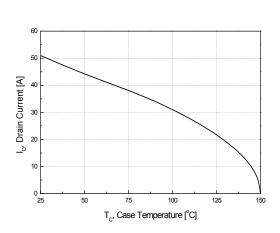
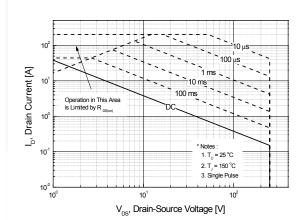


Figure 10. Maximum Drain Current vs. Case Temperature





# **Typical Performance Characteristics** (Continued)

Figure 11-1. Transient Thermal Response Curve for FDP51N25

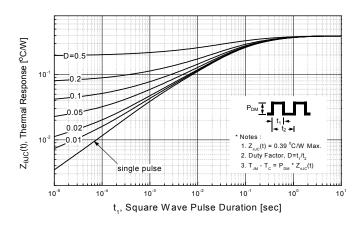
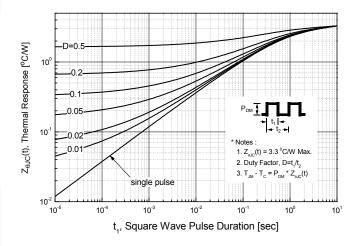


Figure 11-2. Transient Thermal Response Curve for FDPF51N25 / FDPF51N25YDTU



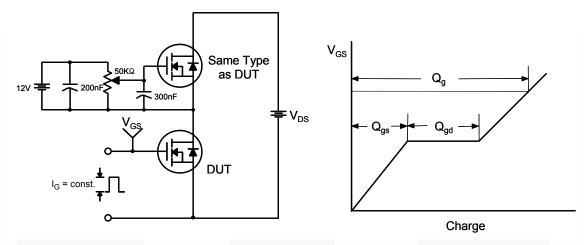


Figure 12. Gate Charge Test Circuit & Waveform

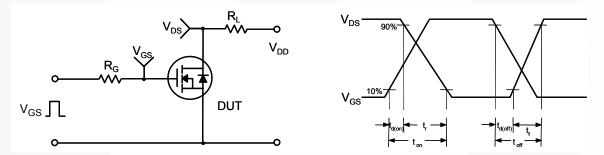


Figure 13. Resistive Switching Test Circuit & Waveforms

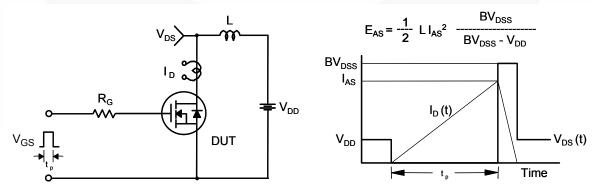


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms

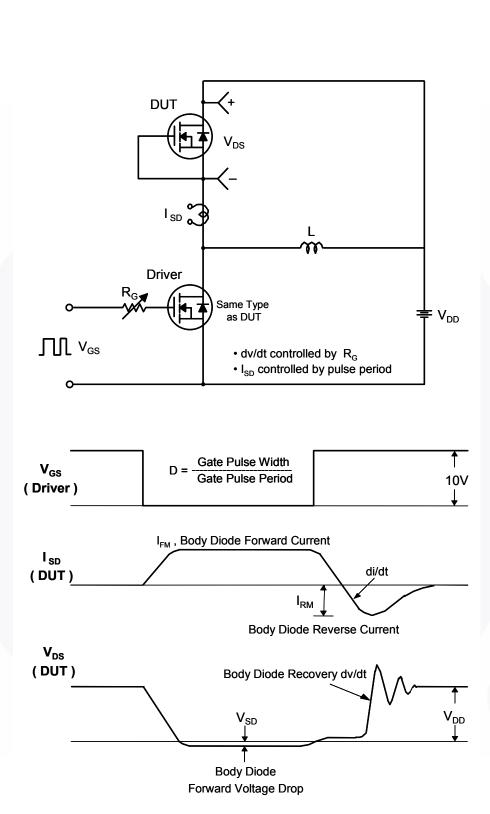
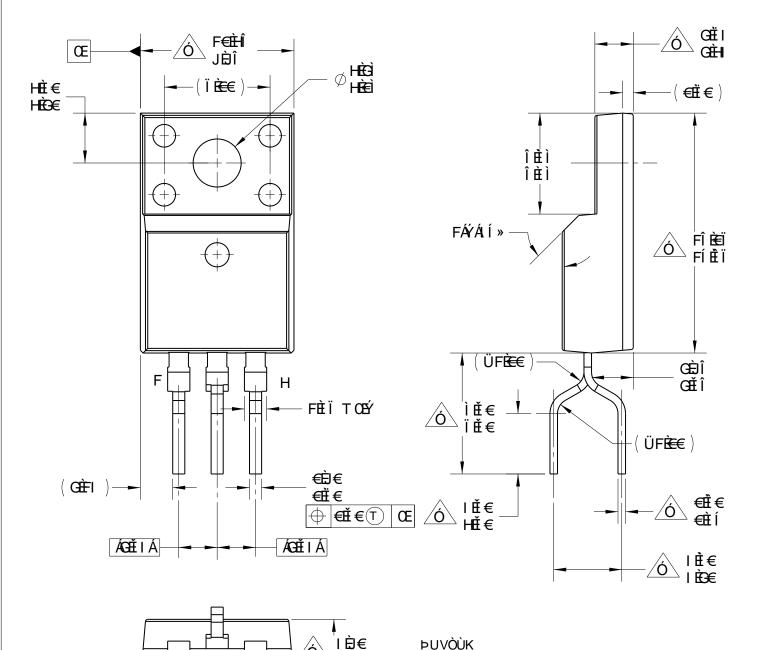


Figure 15. Peak Diode Recovery dv/dt Test Circuit & Waveforms

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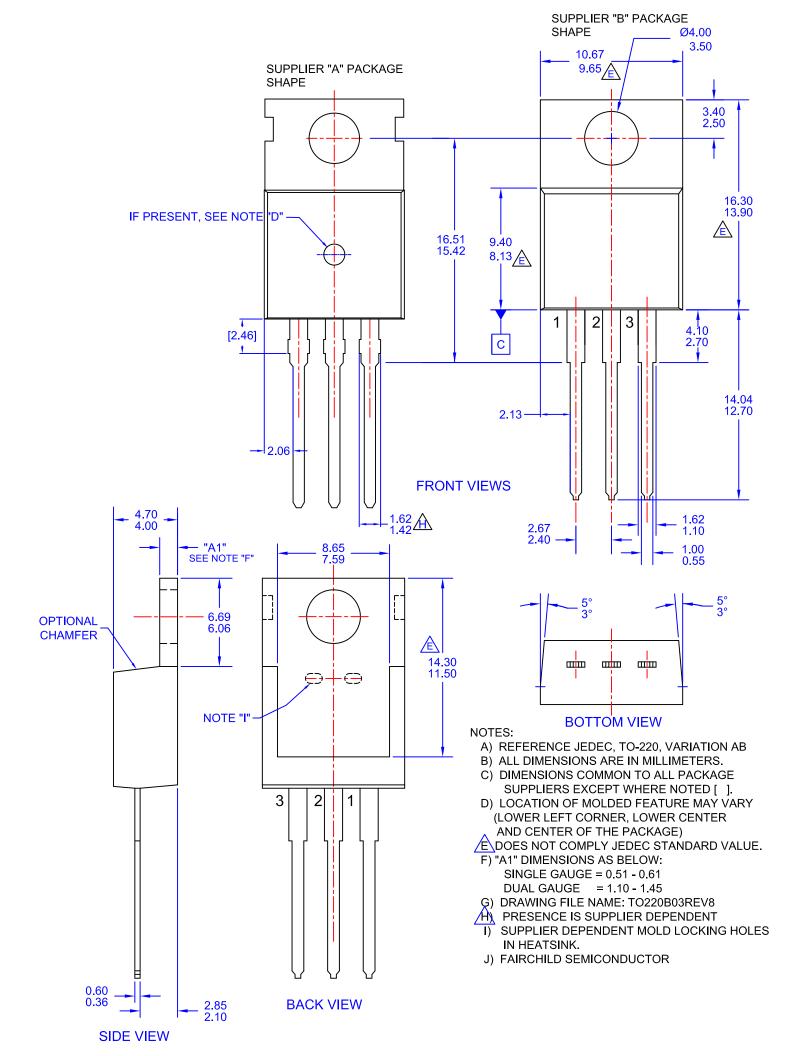
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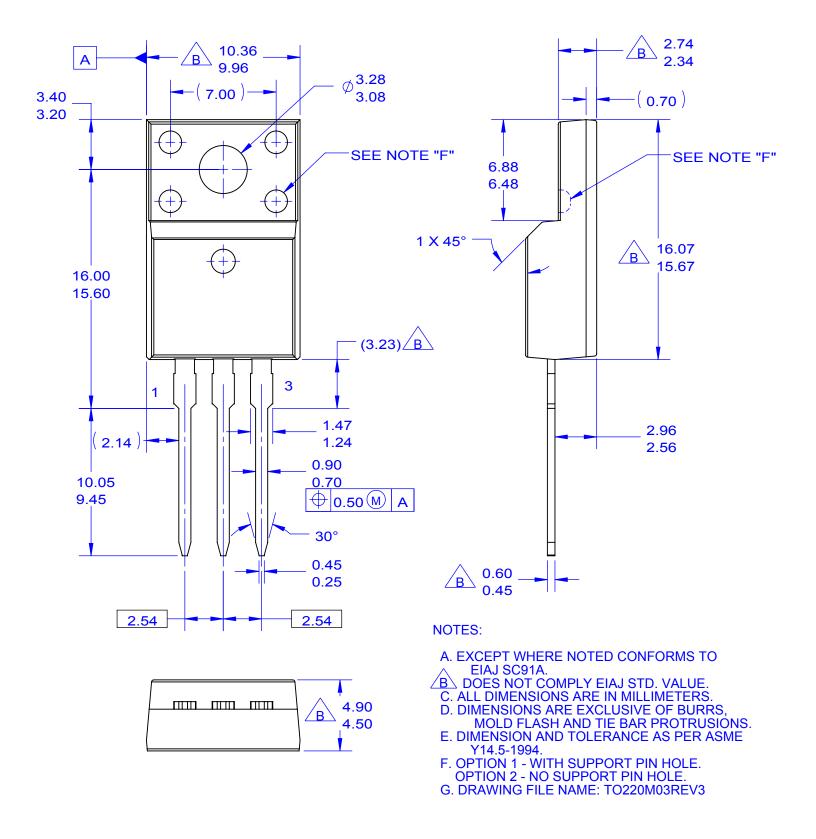
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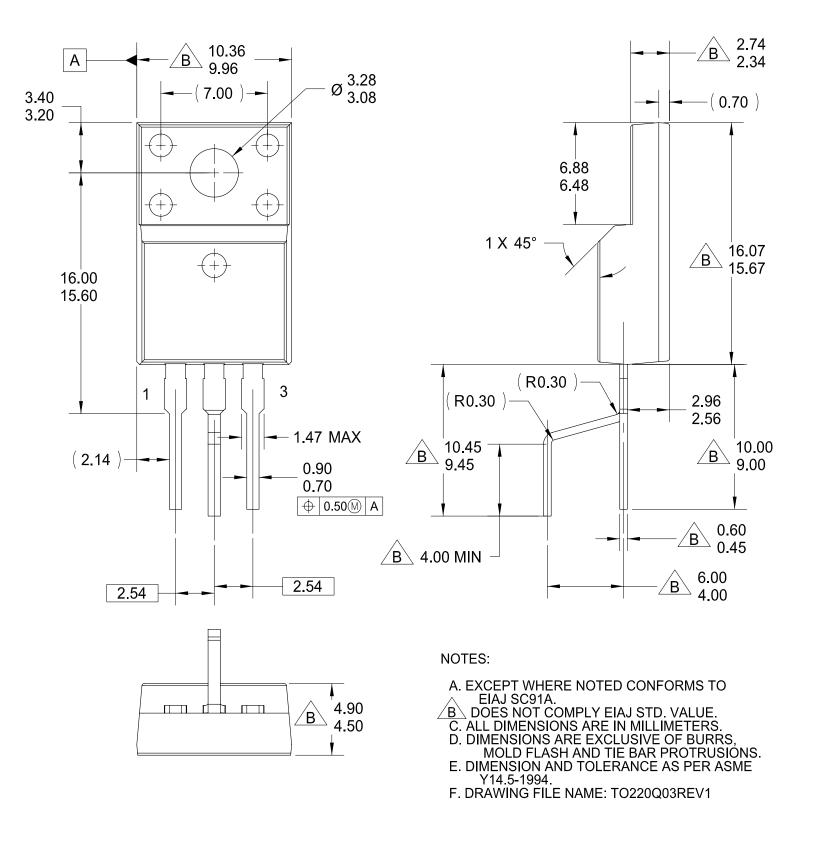
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Rev. 173